

The SENSEI[†] project

how to look for DM-electron scattering events

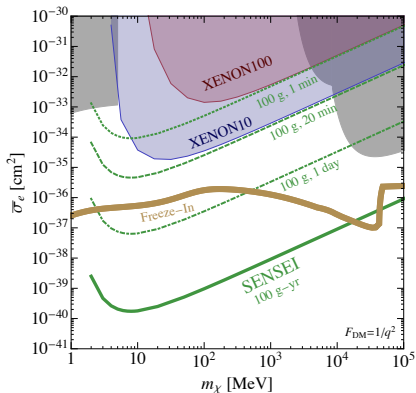
Javier Tiffenberg
Fermi National Laboratory

March 25, 2017

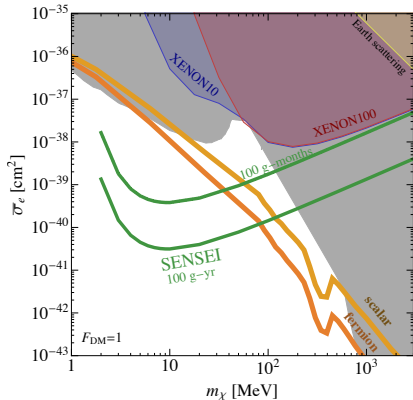
† Sub-Electron-Noise SkipperCCD Experimental Instrument

Motivation for SENSEI: a detector that can do this NOW

Light Dark Photon



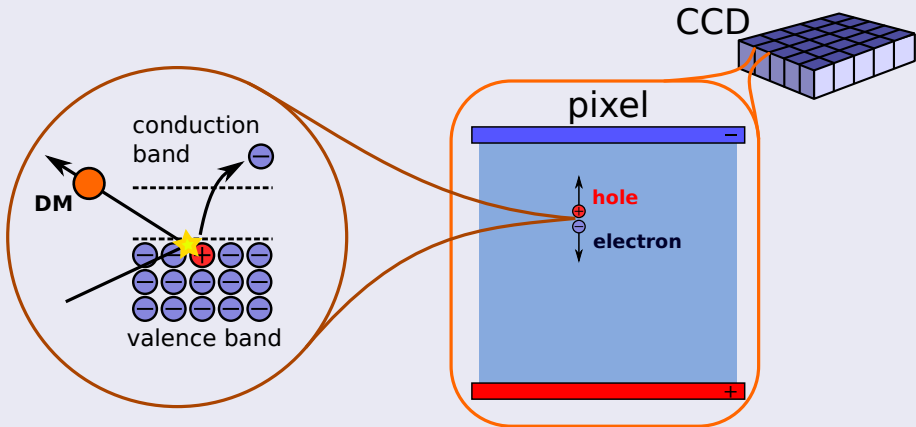
Heavy Dark Photon

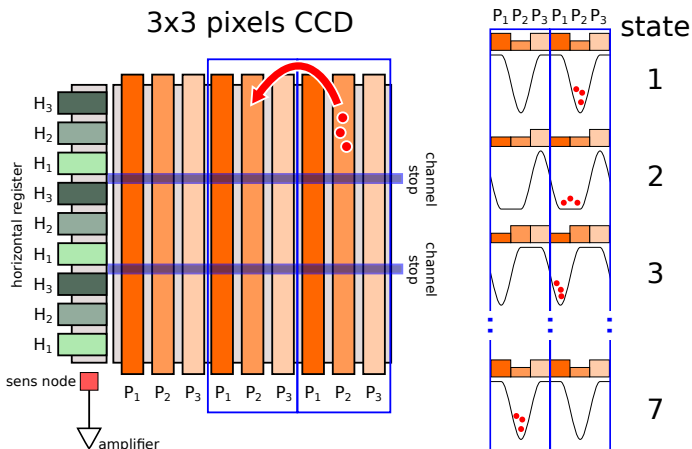


Plots from: Rouven Essig, Tomer Volansky & Tien-Tien Yu.

How?

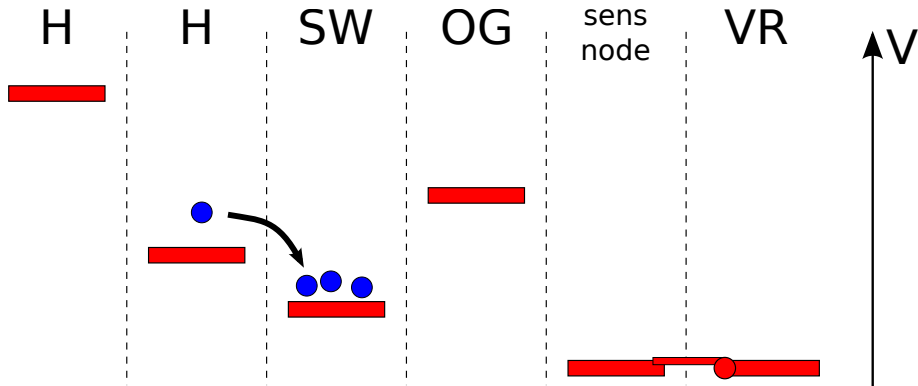
use CCDs as target to record the ionization produced by DM





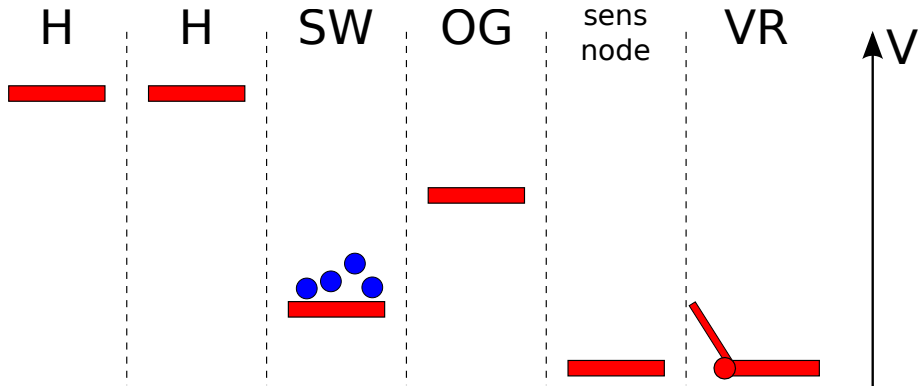
capacitance of the system is set by the SN: $C=0.05\text{pF} \rightarrow 3\mu\text{V}/e$

CCD: readout



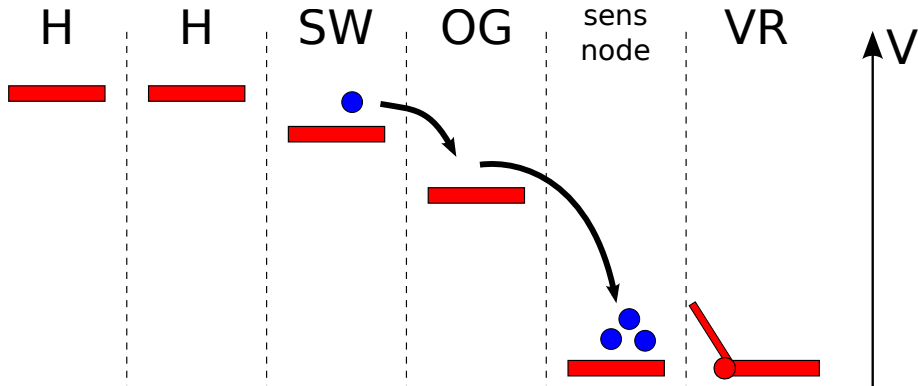
Accumulate the charge in the SW and reset the SN voltage

CCD: readout



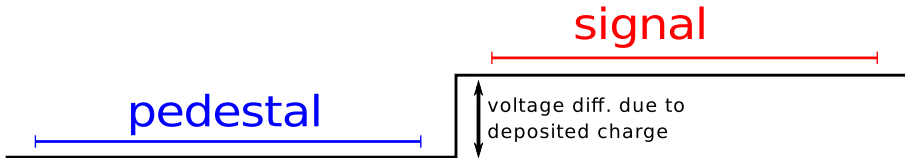
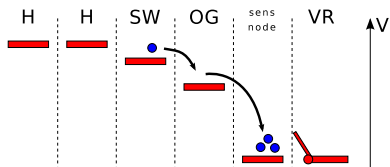
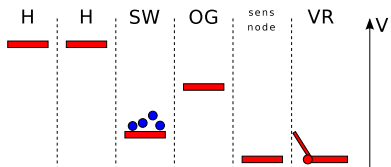
Disconnect the SN so it's floating. Measure the baseline voltage in the SN.

CCD: readout



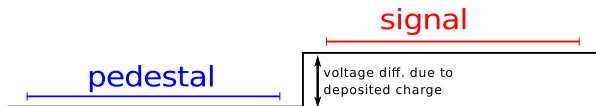
Move the charge to the SN and measure the shift in the voltage

CCD: readout

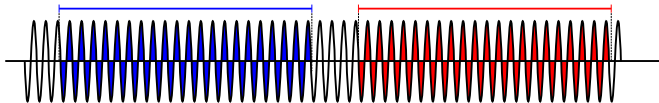


CCD: readout

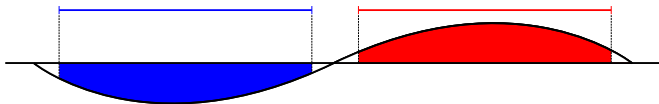
pixel charge
measurement



high frequency
noise

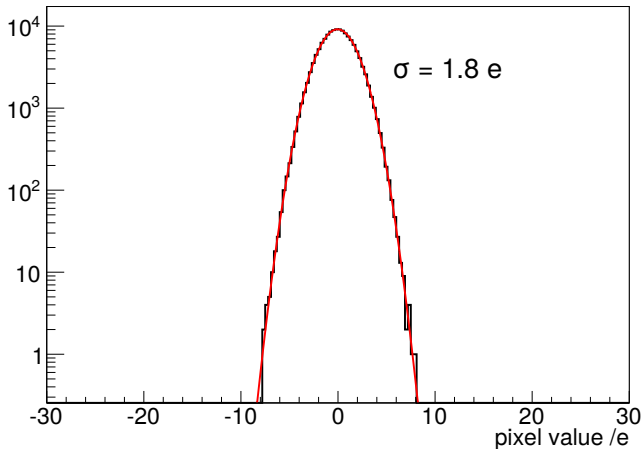


low frequency
noise



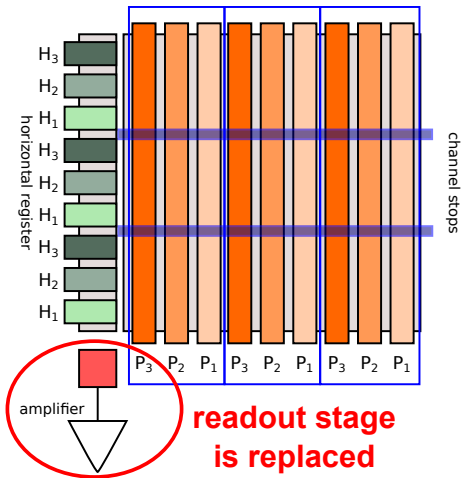
excellent for removing high frequency noise but sensitive to low frequencies

Readout noise: empty pixels distribution



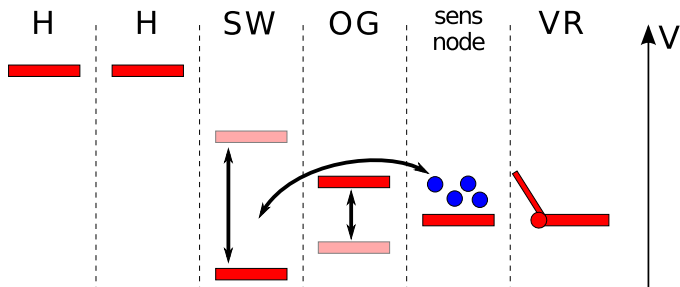
2 e⁻ readout noise roughly corresponds to 50 eV energy threshold

Lowering the noise: Skipper CCD



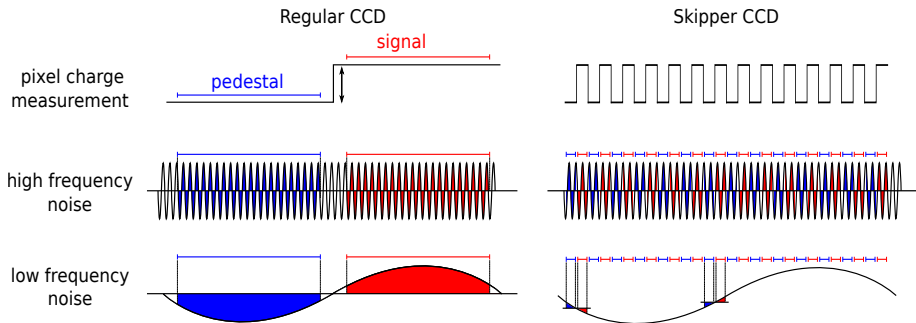
Lowering the noise: Skipper CCD

- **Main difference:** the Skipper CCD allows multiple sampling of the same pixel without corrupting the charge packet.
- The final pixel value is the average of the samples
Pixel value = $\frac{1}{N} \sum_i^N (\text{pixel sample})_i$
- Idea proposed in 1990 by Janesick et al. (doi:10.1117/12.19452)



Lowering the noise: Skipper CCD

- **Main difference:** the Skipper CCD allows multiple sampling of the same pixel without corrupting the charge packet.
- The final pixel value is the average of the samples
Pixel value = $\frac{1}{N} \sum_i^N (\text{pixel sample})_i$
- Idea proposed in 1990 by Janesick et al. (doi:10.1117/12.19452)



Awarded proposal: **Fermilab LDRD 2016** - PI Javier Tiffenberg

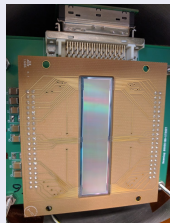
Develop a CCD-based detector with an energy threshold close to the silicon band gap (1.1 eV) and a readout noise of 0.1 electrons using a new generation skipper CCD developed by the **LBNL MicroSystems Lab**

Plan

- Build the first working detector using Skipper-CCDs.
- Optimize the operation parameters and running conditions.
- Produce a low radiation package for the Skipper-CCDs.
- Install the detector in a low radiation environment (MINOS).
- Validate the technology for DM and ν experiments.

SENSEI: First working instrument using SkipperCCD tech

Sensors



- Skipper-CCD prototype designed by **LBL MSL**
- 200 & 250 μm thick, 15 μm pixel size
- Two form factors 4k \times 1k (0.5gr) & 1.2k \times 0.7k pixels
- Parasitic run, optic coating and Si resistivity $\sim 10\text{k}\Omega$
- 4 amplifiers per CCD, three different RO stage designs

Instrument



- System integration done at Fermilab
- Custom cold electronics
- Modified DES electronics for read out
- Firmware and image processing software
- Optimization of operation parameters

Image taken with SENSEI: 4000 samples per pixel (processed)

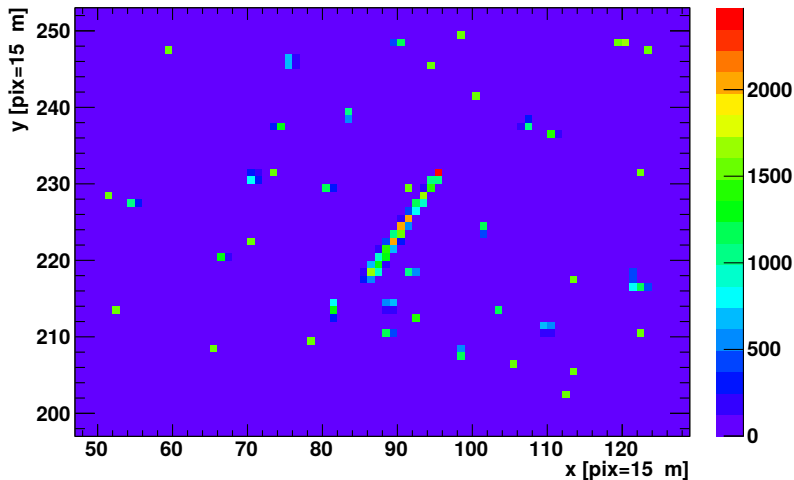


Image taken with SENSEI: 4000 samples per pixel (processed)

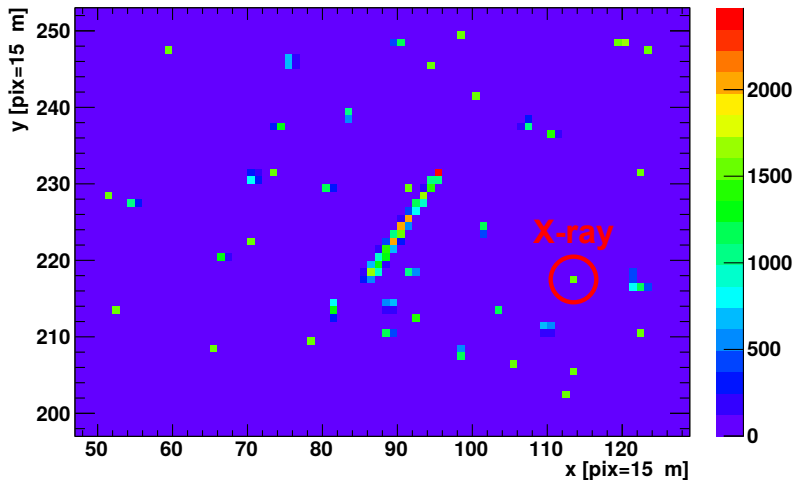


Image taken with SENSEI: 4000 samples per pixel (processed)

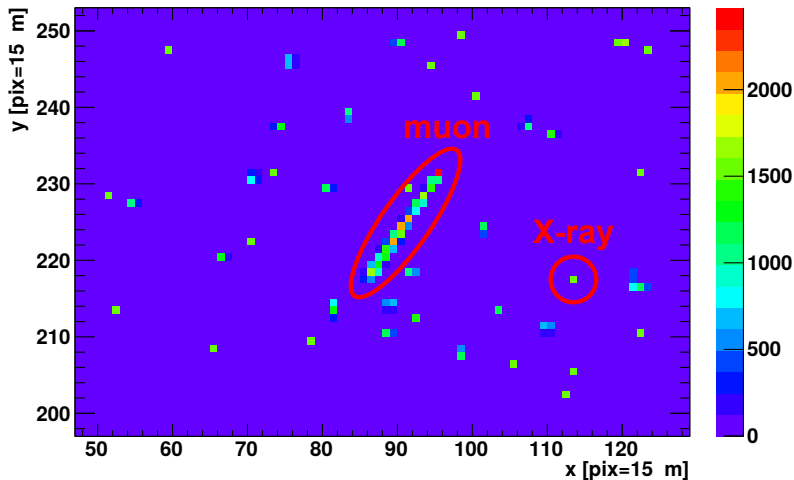
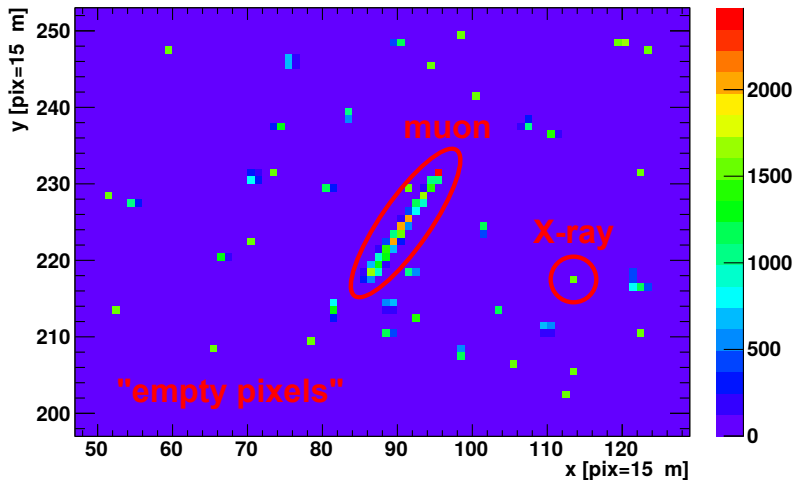
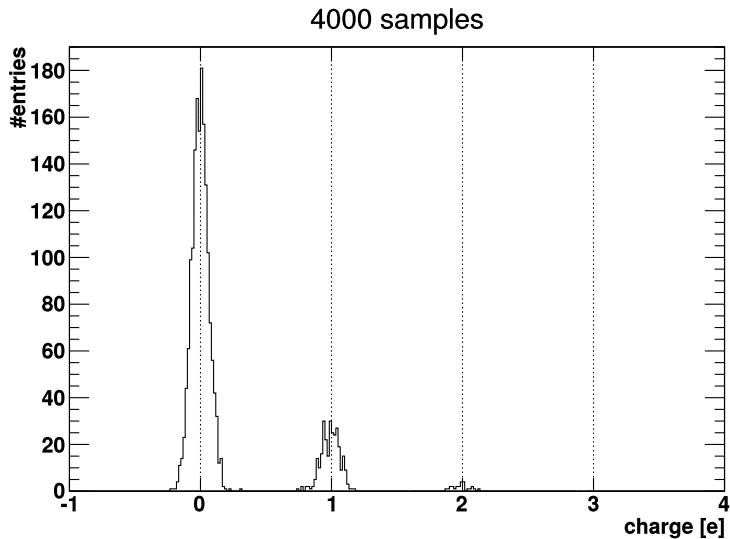


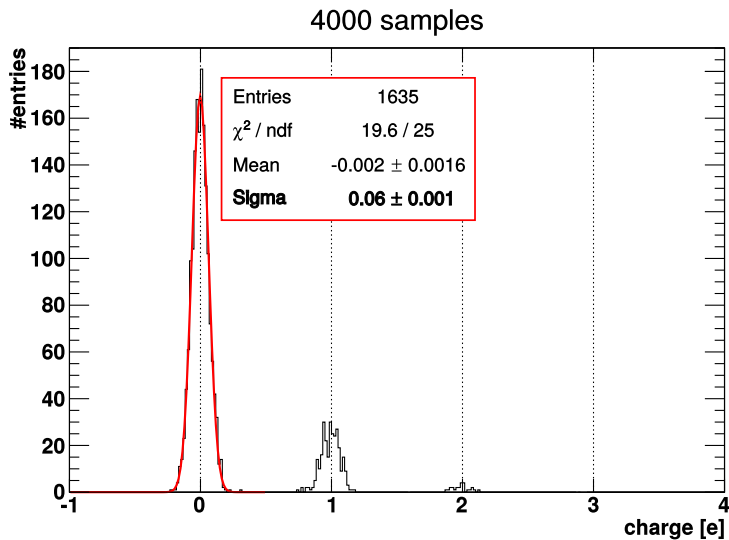
Image taken with SENSEI: 4000 samples per pixel (processed)



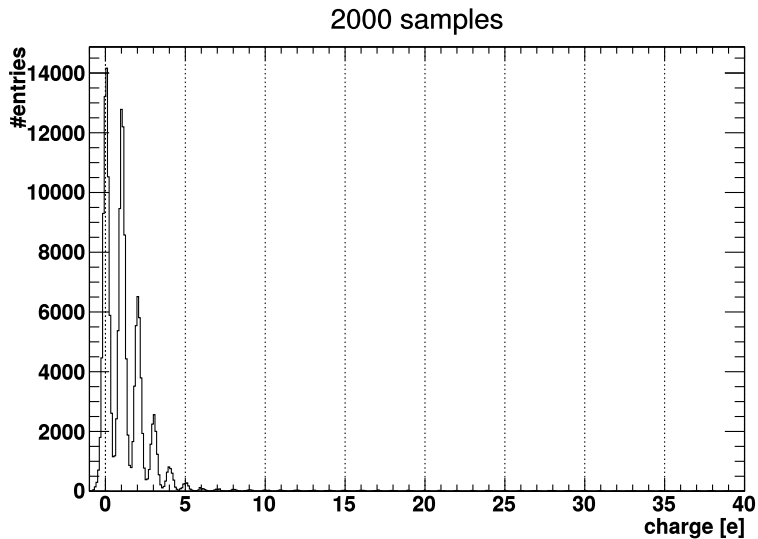
Charge in pixel distribution. Counting electrons: 0, 1, 2..



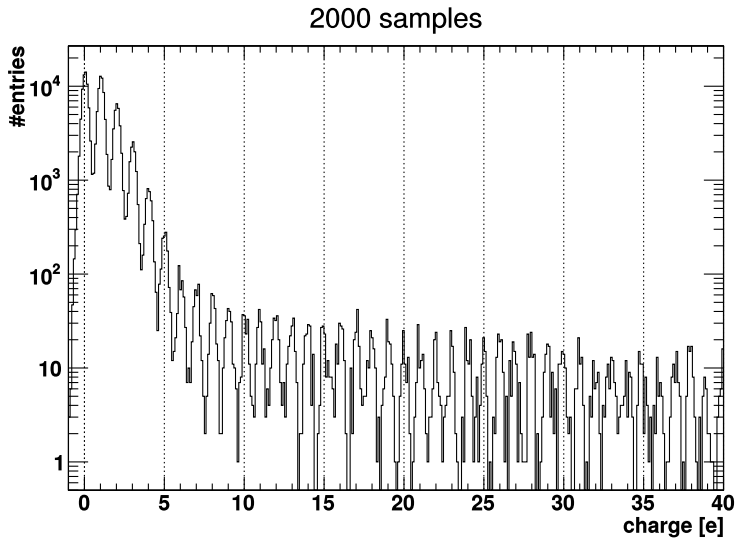
Charge in pixel distribution. Counting electrons: 0, 1, 2..



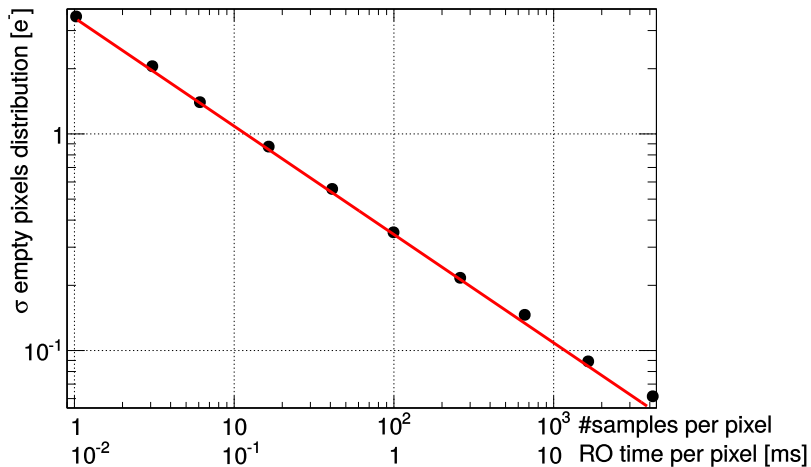
Counting electrons: ..38, 39, 40..



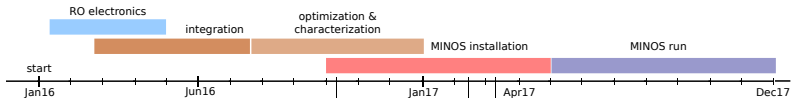
Counting electrons: ..38, 39, 40..



Noise vs. #samples - $1/\sqrt{N}$



Whats next: Installation @MINOS & low radiation package



TSW approved
permission to start operations

Commissioning of 1gr at MINOS by the end of April 2017

SENSEI: DM search operation mode

- Counting electrons \Rightarrow **noise has zero impact**
- It can take about 1h to readout a 4kx4k sensor
- **Dark Current is the limiting factor**

It's better to readout continuously to minimize the impact of the DC

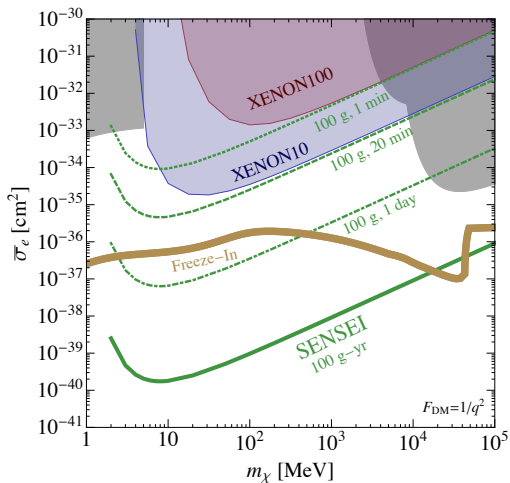
	Number of DC events (100 g y)	
Thr /e	DC = $1 \times 10^{-3} \text{ e pix}^{-1}\text{day}^{-1}$	DC = $10^{-5} \text{ e pix}^{-1}\text{day}^{-1}$
1	1×10^8	7×10^5
2	2×10^4	0.2
3	3×10^{-2}	3×10^{-8}

Measured upper limit for the DC in CCDs is:

$$1 \times 10^{-3} \text{ e pix}^{-1}\text{day}^{-1} \quad \text{arXiv:1611.03066}$$

Could be orders of magnitude lower. **Theoretical prediction is $O(10^{-7})$**

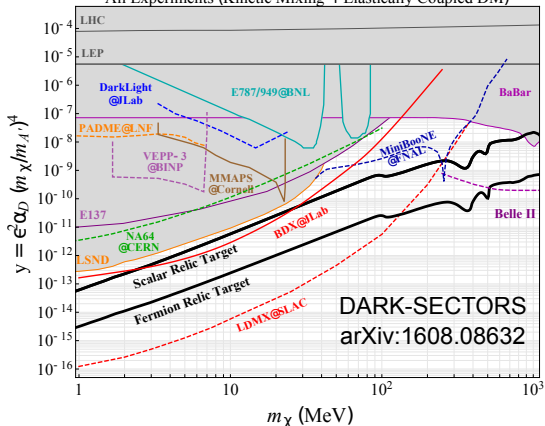
Light Dark Photon



Rouven Essig, Tomer Volansky & Tien-Tien Yu.

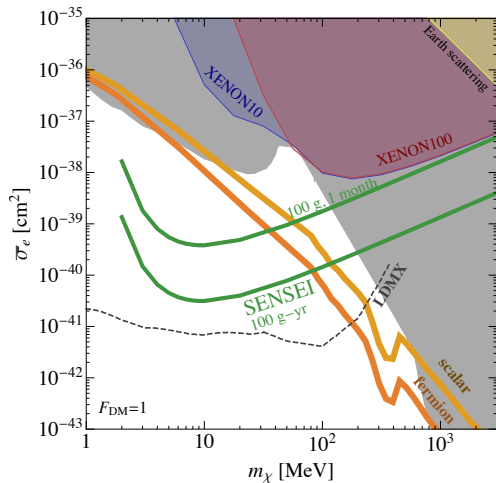
Heavy Dark Photon

All Experiments (Kinetic Mixing + Elastically Coupled DM)



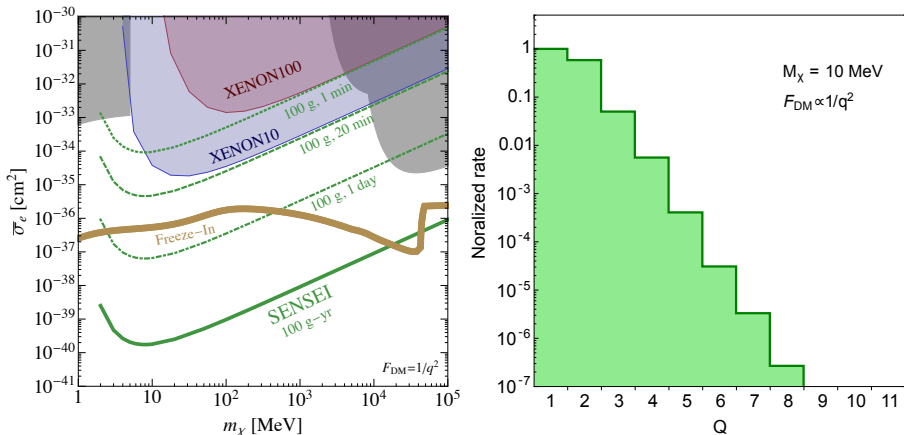
$$\bar{\sigma}_e \simeq \begin{cases} \frac{16\pi\mu_{\chi e}^2\alpha\alpha_D\epsilon^2}{m_{A'}^4}, & m_{A'} \gg \alpha m_e \\ \frac{16\pi\mu_{\chi e}^2\alpha\alpha_D\epsilon^2}{(\alpha m_e)^4}, & m_{A'} \ll \alpha m_e \end{cases}, \text{ and } F_{DM}(q) \simeq \begin{cases} 1, & m_{A'} \gg \alpha m_e \\ \frac{\alpha^2 m_e^2}{q^2}, & m_{A'} \ll \alpha m_e \end{cases}$$

Heavy Dark Photon: complementary to LDMX



Rouven Essig, Tomer Volansky & Tien-Tien Yu.

The sensitivity is dominated by the lowest energy/charge bin



Rouven Essig, Tomer Volansky & Tien-Tien Yu.

Back of the envelope calculation

A 100g detector that takes data for one year \rightarrow **Expo = 36.5kg · day**

Assuming same background as in DAMIC:

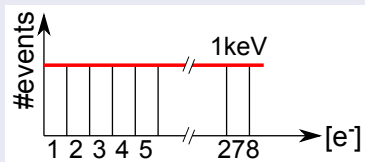
- **5 DRU** ($\text{events} \cdot \text{kg}^{-1} \cdot \text{day}^{-1} \cdot \text{keV}^{-1}$) in the 0-1keV range
 \rightarrow **$N_{\text{bkg}} = 36.5 \text{ kg} \cdot \text{day} \times 5 \text{ DRU} = 182.5$ events**
- Dominated by external gammas \rightarrow **flat Compton spectrum**

Back of the envelope calculation

A 100g detector that takes data for one year \rightarrow **Expo = 36.5kg · day**

Assuming same background as in DAMIC:

- **5 DRU** ($\text{events} \cdot \text{kg}^{-1} \cdot \text{day}^{-1} \cdot \text{keV}^{-1}$) in the 0-1keV range
 $\rightarrow N_{\text{bkg}} = 36.5 \text{ kg} \cdot \text{day} \times 5 \text{ DRU} = 182.5 \text{ events}$
- Dominated by external gammas \rightarrow **flat Compton spectrum**



182.5 events over the 278 charge bins in the 0-1keV range

Expect 0.65 bkd events in the lowest ($2 e^-$) charge-bin

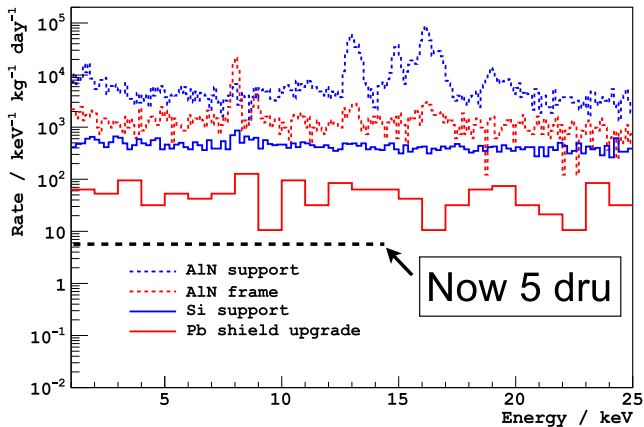
Summary

- Demonstrated technology: working detector
- Demonstrated bkg: no R&D needed.
 - ▶ this level already reached by running experiments
- Minimal R&D required for the packaging of the sensors.
- 100 g construction could start on FY18.
 - ▶ 1.2 M\$ in 2 yrs (scaled from DAMIC experience)
- Complementary to LDMX and DAMIC-1K
- Small scale demonstration at the MINOS. Results by the end of 2017.
- MINOS site is good up to a 10g experiment. SURF/Snolab for 100g.

BACK UP SLIDES

	M&S	Effort	Total
1. Sensors & package	350 k\$	100 k\$	450 k\$
2. Readout electronics	200 k\$	0 k\$	200 k\$
3. Vessel & support systems	115 k\$	100 k\$	215 k\$
4. Installation	0 k\$	50 k\$	50 k\$
5. Contingency	150 k\$	50 k\$	200 k\$
Total	815 k\$	300 k\$	1.15 M\$

DAMIC background spectrum



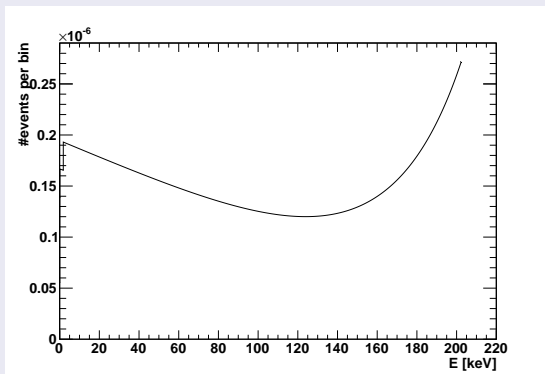
SuperCDMS SNOLAB projected background

"Singles" Background Rates (counts/kg/keV/year)	Electron Recoil				Nuclear Recoil ($\times 10^{-6}$)	
	Ge HV	Si HV	Ge iZIP	Si iZIP	Ge iZIP	Si iZIP
Coherent Neutrinos					2300.	1600.
Detector-Bulk Contamination	21.	290.	8.5	260.		
Material Activation	1.0	2.5	1.9	15.		
Non-Line-of-Sight Surfaces	0.00	0.03	0.01	0.07	-	
Bulk Material Contamination	5.4	14.	12.	88.	440.	660.
Cavern Environment	-	-	-	-	510.	530.
Cosmogenic Neutrons					73.	77.
Total	27.	300.	22.	370.	3300.	2900.

From arXiv:1610.00006

A more detailed analysis: Klein-Nishina + binding energy correction

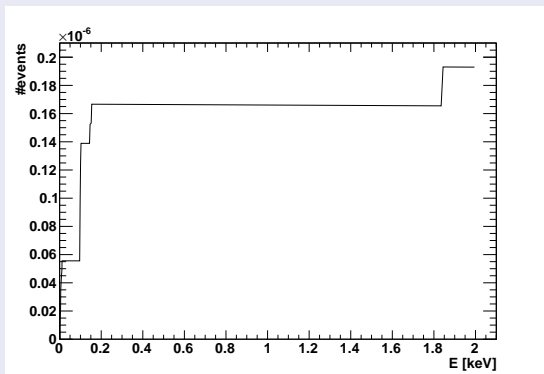
- **at lower energies atomic binding energies are relevant**
- partial energy depositions populate low E region (thin det)



Skipper CCD - electron recoil background requirements

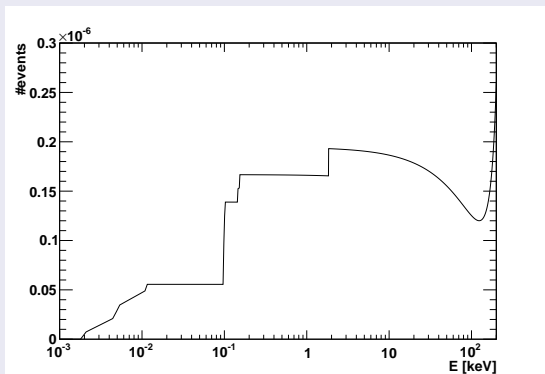
A more detailed analysis: Klein-Nishina + binding energy correction

- at lower energies atomic binding energies are relevant
- partial energy depositions populate low E region (thin det)



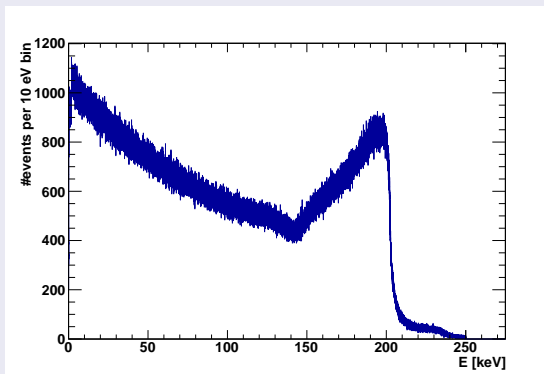
A more detailed analysis: Klein-Nishina + binding energy correction

- **at lower energies atomic binding energies are relevant**
- partial energy depositions populate low E region (thin det)



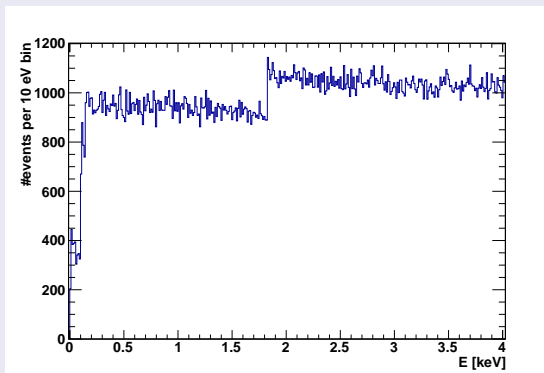
A more detailed analysis: MC simulation, G4 3D Monash model

- at lower energies atomic binding energies are relevant
- **partial energy depositions populate low E region (thin det)**



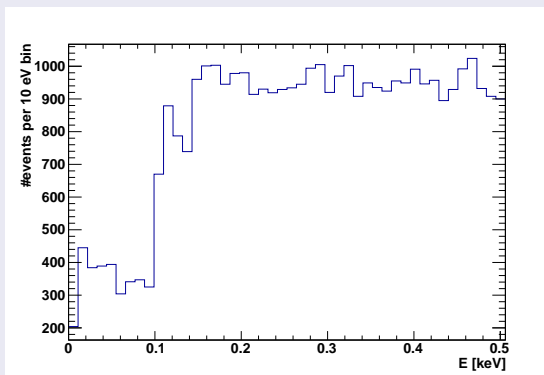
A more detailed analysis: MC simulation, G4 3D Monash model

- at lower energies atomic binding energies are relevant
- **partial energy depositions populate low E region (thin det)**



A more detailed analysis: MC simulation, G4 3D Monash model

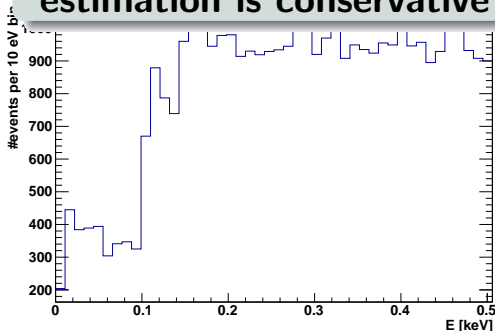
- at lower energies atomic binding energies are relevant
- **partial energy depositions populate low E region (thin det)**



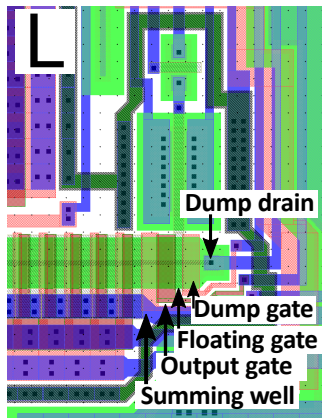
A more detailed analysis: MC simulation, G4 3D Monash model

- at lower energies atomic binding energies are relevant
- **partial energy depositions populate low E region (thin det)**

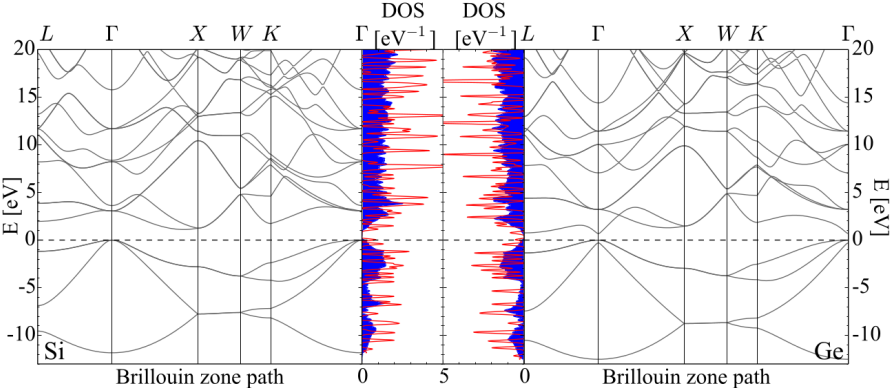
**Back of the envelope
estimation is conservative**



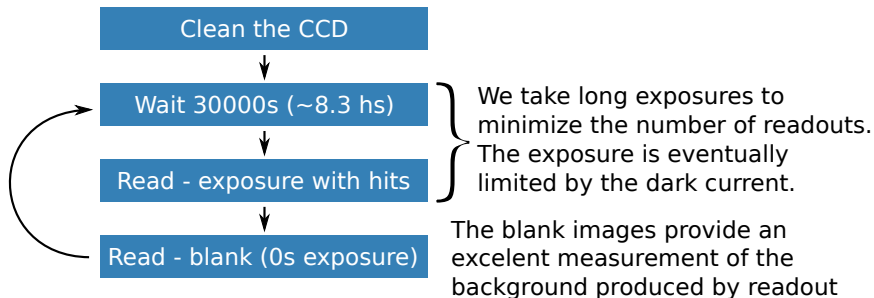
Readout stage design



Electron density-of-states (1509.1598)



CCD: readout - typical operation for rare events searches

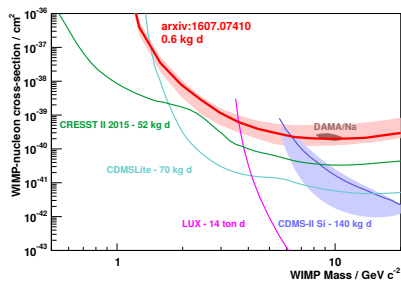


- The number of **real** events (produced by particles) scales with the total exposure time.
- The number of **fake** events (product of readout noise) scale with the number of readings (images taken).

It is better to read as few times as possible.

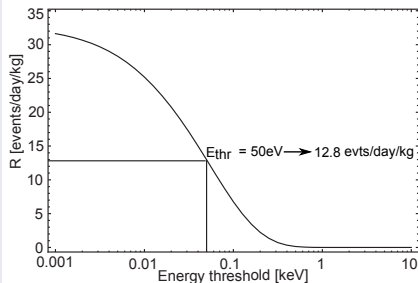
Status of the experiments

DAMIC



- Eng WIMP search: 1607.07410
- Fully commissioned Jan-17

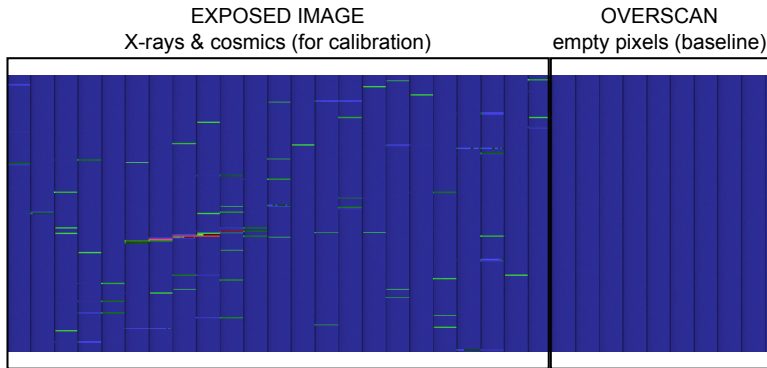
CONNIE



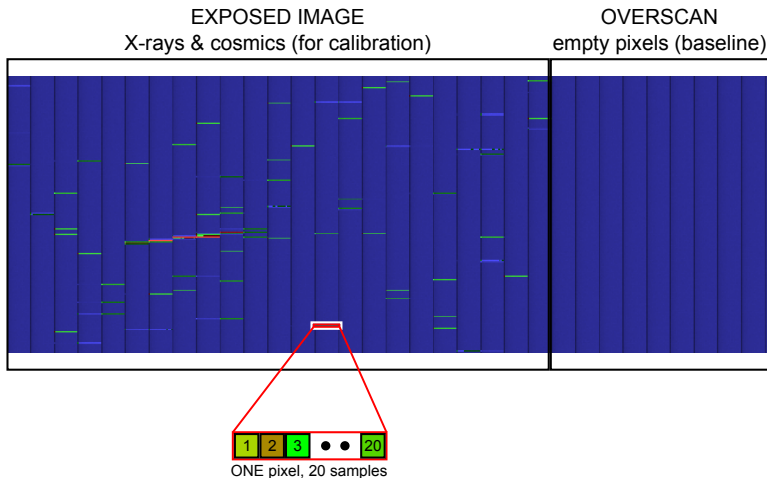
- Eng run: 1604.01343
- Fully commissioned Aug-16

Both searches are limited by the readout noise of the sensors
Very limited electron-recoil sensitivity: threshold $\sim 10\text{e}^-$

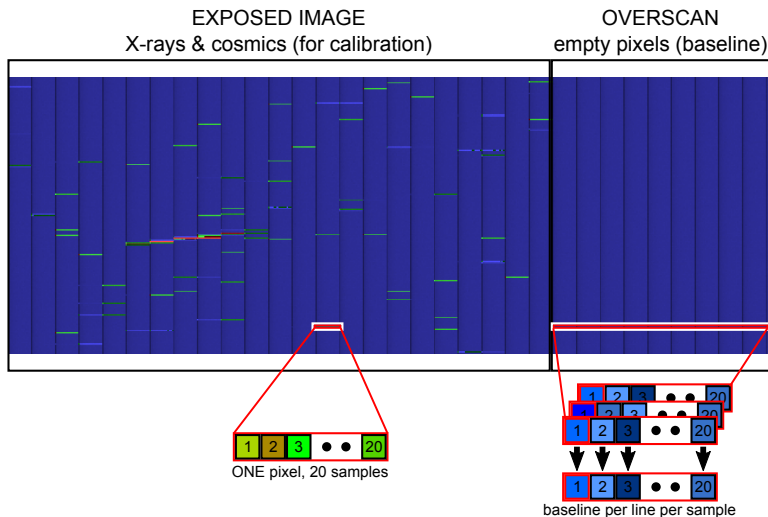
Raw image taken with SENSEI: 20 samples per pixel



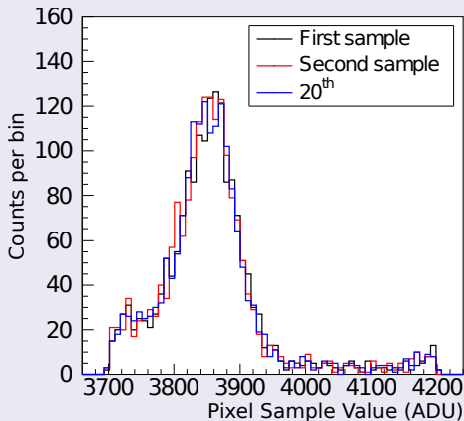
Raw image taken with SENSEI: 20 samples per pixel



Raw image taken with SENSEI: 20 samples per pixel

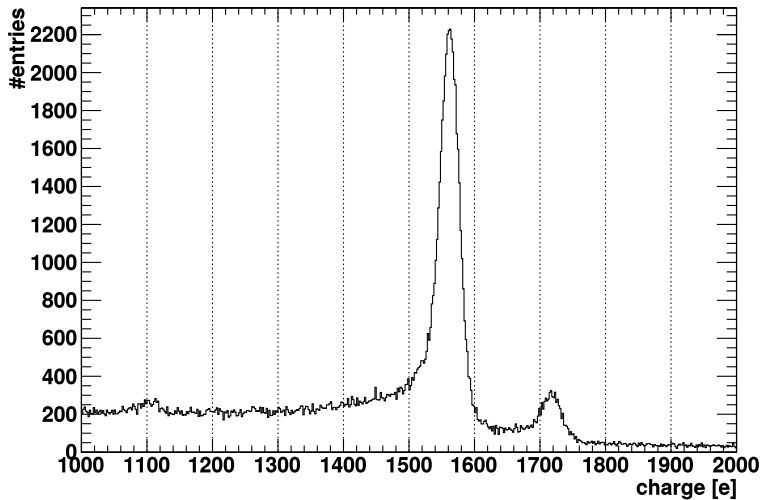


Single pixel distribution: X-rays from ^{55}Fe

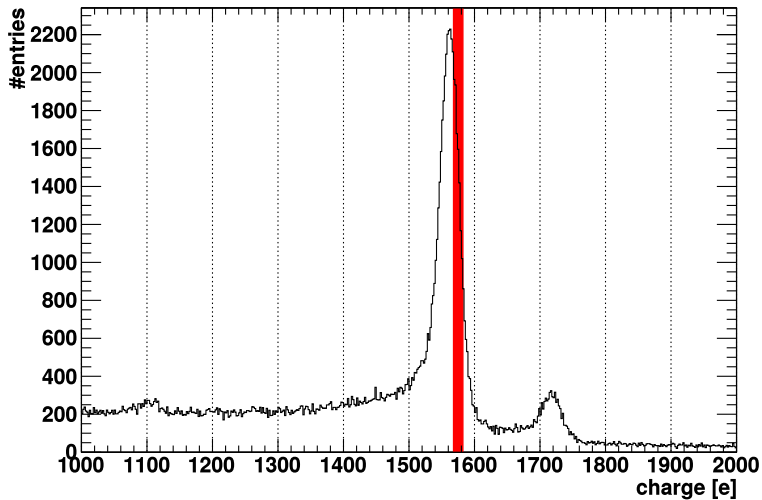


The gain is the same for all the samples

500 samples



500 samples



keep counting: ..1575, 1576, 1577..

